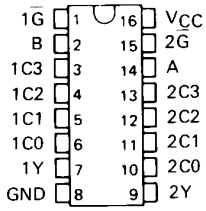
SN54LS253, SN54S253, SN74LS253, SN74S253
DUAL 4-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS WITH 3-STATE OUTPUTS

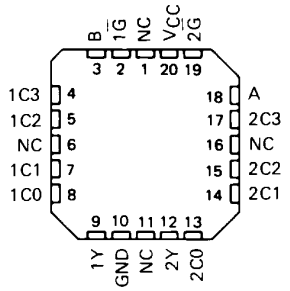
SEPTEMBER 1972 – REVISED MARCH 1988

- **Three-State Version of SN54/74LS153, SN54/74S153**
- **Schottky-Diode-Clamped Transistors**
- **Permits Multiplexing from N Lines to 1 Line**
- **Performs Parallel-to Serial Conversion**
- **Fully Compatible with Most TTL Circuits**
- **Low Power Dissipation**
  'LS253 . . . 35 mW Typical
  'S253 . . . 225 mW Typical

SN54LS253, SN54S253 . . . J OR W PACKAGE
SN74LS253, SN74S253 . . . D OR N PACKAGE
(TOP VIEW)



SN54LS253, SN54S253 . . . FK PACKAGE
(TOP VIEW)



NC-No internal connection

description

Each of these Schottky-clamped data selectors/multiplexers contains inverters and drivers to supply fully complementary, on-chip, binary decoding data selection to the AND-OR gates. Separate output control inputs are provided for each of the two four-line sections.

The three-state outputs can interface with and drive data lines of bus-organized systems. With all but one of the common outputs disabled (at a high-impedance state) the low-impedance of the single enabled output will drive the bus line to a high or low logic level.

FUNCTION TABLE

SELECT INPUTS		DATA INPUTS				OUTPUT CONTROL	OUTPUT
B	A	C0	C1	C2	C3	$\overline{G}$	Y
X	X	X	X	X	X	H	Z
L	L	L	X	X	X	L	L
L	L	H	X	X	X	L	H
L	H	X	L	X	X	L	L
L	H	X	H	X	X	L	H
H	L	X	X	L	X	L	L
H	L	X	X	H	X	L	H
H	H	X	X	X	L	L	L
H	H	X	X	X	H	L	H

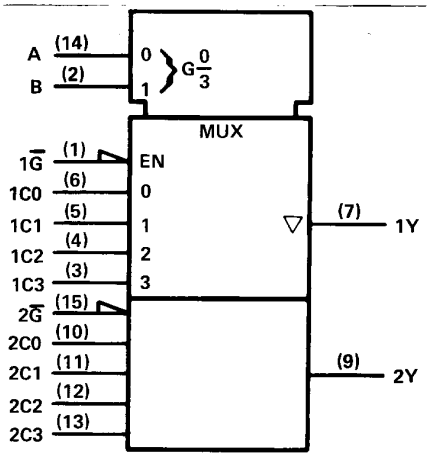
Address inputs A and B are common to both sections.
H = high level, L = low level, X = irrelevant, Z = high impedance (off)

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1) . . . . . 7 V
Input voltage: 'LS253 . . . . . 7 V
'S253 . . . . . 5.5 V
Off-state output voltage . . . . . 5.5 V
Operating free-air temperature range: SN54LS253, SN54S253 . . . . . −55°C to 125°C
SN74LS253, SN74S253 . . . . . 0°C to 70°C
Storage temperature range . . . . . −65°C to 150°C

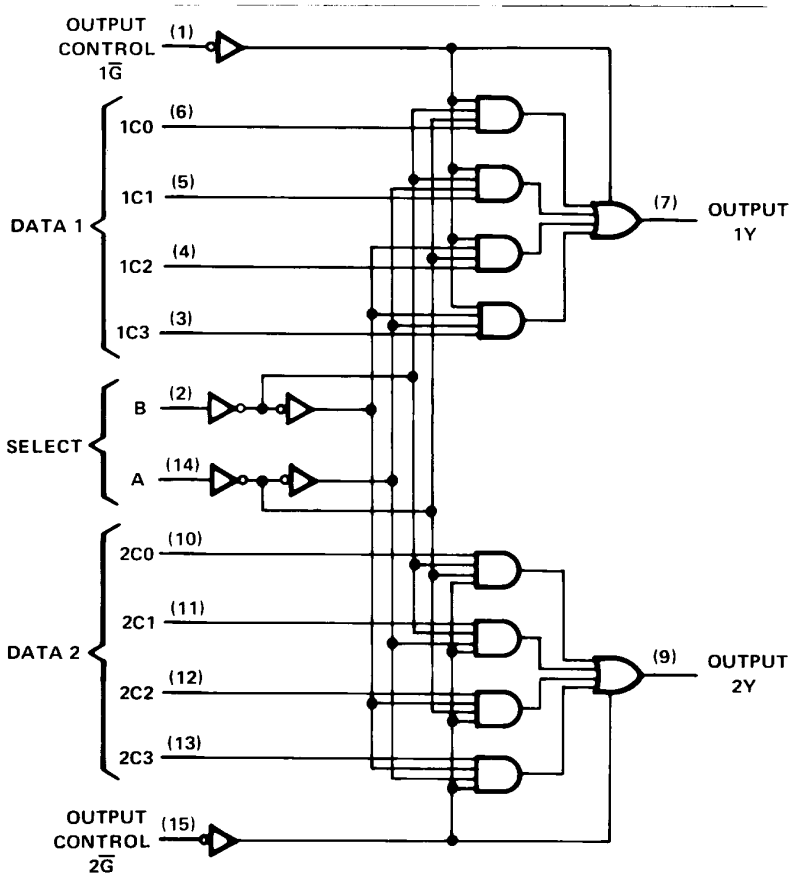
NOTE 1: Voltage values are with respect to network ground terminal.

logic symbol†



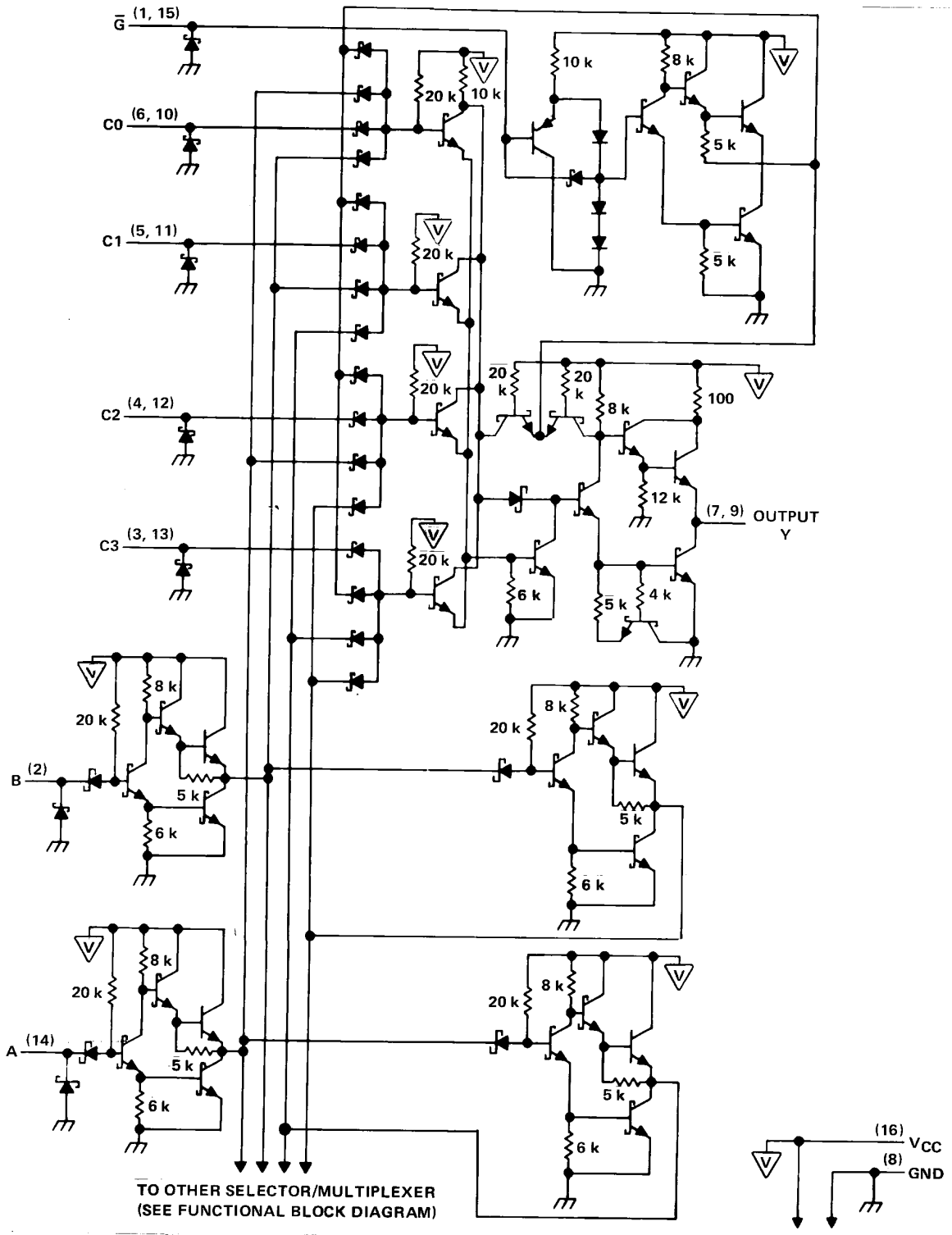
† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



Pin numbers shown are for D, J, N, and W packages.

schematic (each selector/multiplexer, and the common select section)



Pin numbers shown are for D, J, N, and W packages.

recommended operating conditions

		SN54LS253			SN74LS253			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.7			0.8	V
I_{OH}	High-level output current			−1			−2.6	mA
I_{OL}	Low-level output current			4			8	mA
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†		SN54LS253			SN74LS253			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}	V_{CC} = MIN, I_I = −18 mA				−1.5			−1.5	V
V_{OH}	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = MAX,	I_{OH} = MAX	2.4	3.4		2.4	3.1		V
V_{OL}	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = MAX	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	V
		I_{OL} = 8 mA					0.25	0.5	
I_{OZ}	V_{CC} = MAX, V_{IH} = 2 V	V_O = 2.7 V			20			20	μA
		V_O = 0.4 V			−20			−20	
I_I	V_{CC} = MAX, V_I = 7 V				0.1			0.1	mA
I_{IH}	V_{CC} = MAX, V_I = 2.7 V				20			20	μA
I_{IL}	V_{CC} = MAX, V_I = 0.4 V	$\overline{G}$			−0.2			−0.2	mA
		All other			−0.4			−0.4	
I_{OS}§	V_{CC} = MAX		−30		−130	−30		−130	mA
I_{CC}	V_{CC} = MAX, See Note 2	Condition A		7	12		7	12	mA
		Condition B		8.5	14		8.5	14	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ Not more than one output should be shorted at a time, and duration for the short-circuit should exceed one second.
NOTE 2: I_{CC} is measured with the outputs open under the following conditions:
A. All inputs grounded.
B. Output control at 4.5 V, all inputs grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	Data	Y	C_L = 15 pF, R_L = 2 kΩ, See Note 3		17	25	ns
t_{PHL}					13	20	
t_{PLH}	Select	Y			30	45	ns
t_{PHL}					21	32	
t_{PZH}	Output Control	Y			15	28	ns
t_{PZL}					15	23	
t_{PHZ}	Output Control	Y	C_L = 5 pF, R_L = 2 kΩ, See Note 3		27	41	ns
t_{PLZ}					18	27	

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

TEXAS INSTRUMENTS
POST OFFICE BOX 655012 • DALLAS, TEXAS 75265

recommended operating conditions

		SN54S253			SN74S253			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage	2			2			V
V_{IL}	Low-level input voltage			0.8			0.8	V
I_{OH}	High-level output current			−2			−6.5	mA
I_{OL}	Low-level output current			20			20	mA
T_A	Operating free-air temperature	−55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†		MIN	TYP‡	MAX	UNIT
V_{IK}	V_{CC} = MIN, I_I = −18 mA				−1.2	V
V_{OH}	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OH} = MAX	Series 54S	2.5	3.4		V
		Series 74S	2.7	3.4		
V_{OL}	V_{CC} = MIN, V_{IH} = 2 V, V_{IL} = 0.8 V, I_{OL} = 20 mA				0.5	V
I_{OZ}	V_{CC} = MAX, V_{IH} = 2 V	V_O = 2.4 V			50	μA
		V_O = 0.5 V			−50	
I_I	V_{CC} = MAX, V_I = 5.5 V				1	mA
I_{IH}	V_{CC} = MAX, V_I = 2.7 V				50	μA
I_{IL}	V_{CC} = MAX, V_I = 0.5 V	$\overline{G}$ = 0.8 V,			−2	mA
		$\overline{G}$ = 2 V			−0.25	
I_{OS}§	V_{CC} = MAX		−40		−100	mA
I_{CC}	V_{CC} = MAX, See Note 2	Condition A		45	70	mA
		Condition B		65	85	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.
‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.
§ Not more than one output should be shorted at a time and duration of short-circuit should not exceed one second.
NOTE 2: I_{CC} is measured with the outputs open under the following conditions:
A. All inputs grounded.
B. Output control at 4.5 V, all inputs grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{PLH}	Data	Y	R_L = 280 Ω, C_L = 15 pF, See Note 3		6	9	ns
t_{PHL}					6	9	
t_{PLH}	Select	Y			11.5	18	ns
t_{PHL}					12	18	
t_{PZH}	Output Control	Y			11	16.5	ns
t_{PZL}					12	18	
t_{PHZ}	Output Control	Y	R_L = 280 Ω, C_L = 5 pF, See Note 3		6.5	9.5	ns
t_{PLZ}					10	15	

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.